

Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 1 of 12

FCC Test Report

 Applicant
 : GCteq Wireless (shenzhen) Co., Ltd

 Address
 No. A402, Floor 4, Suojia Science park

 Complex Building, Sanwei Community,

 Hangcheng Street, Bao 'an District, Shenzhen

 City, Guangdong Province China

Product Name : Embedded Multi-Functional Charging Table

Report Date : Jan. 18, 2024



Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 2 of 12

Contents

 1.1. Client Information 1.2. Description of Device (EUT) 1.3. Auxiliary Equipment Used During Test 1.4. Test Equipment List
1.3. Auxiliary Equipment Used During Test 1.4. Test Equipment List
1.4. Test Equipment List
1.5. Measurement Uncertainty
1.6. Description of Test Facility
1.7. Disclaimer
2. Measurement and Result
2.1. Requirements
2.2. Test Setup
2.3. Test Procedure
2.4. Test Result1
APPENDIX I TEST SETUP PHOTOGRAPH
APPENDIX II EXTERNAL PHOTOGRAPH1
APPENDIX III INTERNAL PHOTOGRAPH1

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com Code:AB-RF-05-b





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 3 of 12

TEST REPORT

Applicant	:	GCteq Wireless (shenzhen) Co., Ltd
Manufacturer	(e) ¹	GCteq Wireless (shenzhen) Co., Ltd
Product Name	100	Embedded Multi-Functional Charging Table
Test Model No.	25	GF-17Lite-01B
Reference Model No.	:	GF-17Lite-01SP, GF-17Lite-01U, GF-17Lite-03B, GF-17Lite-03SP, GF-17Lite-03U, GF-17Lite-03BP
Trade Mark Rating(s)	ek pot	GCteq Input:24-36VDC/ 3-2A Wireless output: 15W Max Type-C output: 30W Max USB -A output: 18W Max
Test Standard(s) :	F	CC Part 1 1310 1 1307(b)

Test Standard(s):FCC Part 1.1310, 1.1307(b)Test Method(s):KDB 680106 D01 Wireless Power Transfer v04

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 1.1307 & KDB680106 D01 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt Date of Test

Prepared By

Dec. 20, 2023 Dec. 20, 2023~Jan. 09, 2024

Jan Ella

(Ella Liang)

Idward pan

(Edward Pan)

ek Anbote Anu tek ant

Approved & Authorized Signer

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 4 of 12

Report Version			Description	Issued Date			
R00 R00		Anboten	Original Issu	Jan. 18, 2024			
Anboro	K nbotek	Anboten	Anbo	Anbotek	Anbore	Aunobotek	Anbore
Anbo	A. stek	nboto	Ann	botek	Anbo	phillippi	np

Revision History

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com Code:AB-RF-05-b





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 5 of 12

1. General Information

1.1. Client Information

Applicant	: GCteq Wireless (shenzhen) Co., Ltd
Address	 No. A402, Floor 4, Suojia Science park Complex Building, Sanwei Community, Hangcheng Street, Bao 'an District, Shenzhen City, Guangdong Province China
Manufacturer	: GCteq Wireless (shenzhen) Co., Ltd
Address	 No. A402, Floor 4, Suojia Science park Complex Building, Sanwei Community, Hangcheng Street, Bao 'an District, Shenzhen City, Guangdong Province China
Factory	: TEN PAO EIECTRONICS(HUIZHOU) Co.,LTD.
Address	dongjiang industrial Estate, shuikou Street, Huizhou City, Guangdong Province, P.R.C

1.2. Description of Device (EUT)

P	1 m	And ak about An y water And
Product Name	:	Embedded Multi-Functional Charging Table
Test Model No.	:	GF-17Lite-01B
Reference Model No.	:	GF-17Lite-01SP, GF-17Lite-01U, GF-17Lite-03B, GF-17Lite-03SP, GF-17Lite-03U, GF-17Lite-03BP (Note: All samples are the same except the model number, socket, button and appearance color, so we prepare "GF-17Lite-01B" for test only.)
Trade Mark	:	GCteq
Test Power Supply	:	AC 120V, 60Hz for adapter
Test Sample No.	:	1-2-1(Normal Sample), 1-2-2(Engineering Sample)
Adapter	:	N/A* Anbotek Anbotek Anbotek Anbotek Anbotek
RF Specification		
Operation Frequency	:	115-205kHz
Modulation Type	:	ASK Anborek Anborek Anborek Anborek Anborek Anborek Anborek
Antenna Type	:	Inductive loop coil Antenna
Antenna Gain(Peak)	:	0 dBi
101	-	pecification are provided by customer. 2) For a more detailed features the manufacturer's specifications or the User's Manual.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 6 of 12

1.3. Auxiliary Equipment Used During Test

Description	Rating(s)
Adapter	Model: S058AAC2900200
Anbo ok botek	Input: 100-240V~50/60Hz 2.4A
Anbore Ant	Output: 29.0V-2.0A, 29.0V-4.0A
Wireless charging load:	Manufacturer: Shenzhen Ouju Technology Co., Ltd.
tek nbotek An	M/N: CD2577
upo" An botek	Power: 5W/7.5W/10W/15W

1.4. Test Equipment List

	- AV		1		NO: AV		Market States and Stat
N.	Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
	ek P	Electric and	k hotek	Anbotek P	upo. k.	abotek Ant	ote. Anu
0	1	Magnetic field	NARDA	EHP-200A	180ZX10202	Oct. 16, 2023	1 Year
		Analyzer	otek Anbore	Annetek	nboten	Anbo	botek

1.5. Measurement Uncertainty

Magnetic Field Reading(A/m)	:	+/-0.04282(A/m)	Anbotek	Anbo	Anbotek	Anbote
Electric Field Reading(V/m)	:	+/-0.03679(V/m)	Anbo	Anbotek	Anborek	An
Tiek abor h.	c .	ale. Don			E 000	N.

The measurement uncertainty and decision risk evaluated according to AB/WI-RF-F-032. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com Code:AB-RF-05-b Hotline 400-003-0500

www.anbotek.com.cn



Anbotek Product Safety

Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 7 of 12

1.6. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 434132

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 434132.

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.

1.7. Disclaimer

- 1. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- 2. The test report is invalid if there is any evidence and/or falsification.
- 3. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- 4. This document may not be altered or revised in any way unless done so by Anbotek and all revisions are duly noted in the revisions section.
- 5. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- 6. The authenticity of the information provided by the customer is the responsibility of the customer and the laboratory is not responsible for its authenticity.

The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 8 of 12

2. Measurement and Result

2.1. Requirements

According to the item 5.b) of KDB 680106 D01v04:

Inductive wireless power transfer applications that meet all of the following requirements are excluded from submitting an RF exposure evaluation.

- (1) The power transfer frequency is below 1 MHz.
- (2) The output power from each transmitting element (e.g., coil) is less than or equal to 15 watts.

(3) A client device providing the maximum permitted load is placed in physical contact with the transmitter (i.e., the surfaces of the transmitter and client device enclosures need to be in physical contact)

(4) Only § 2.1091-Mobile exposure conditions apply (i.e., this provision does not cover § 2.1093-Portable exposure conditions).

(5) The E-field and H-field strengths, at and beyond 20 cm surrounding the device surface, are demonstrated to be less than 50% of the applicable MPE limit, per KDB 447498, Table 1. These measurements shall be taken along the principal axes of the device, with one axis oriented along the direction of the estimated maximum field strength, and for three points per axis or until a 1/d (inverse distance from the emitter structure) field strength decay is observed. Symmetry considerations may be used for test reduction purposes. The device shall be operated in documented worst-case compliance scenarios (i.e., the ones that lead to the maximum field components), and while all the radiating structures (e.g., coils or antennas) that by design can simultaneously transmit are energized at their nominal maximum power.

(6) For systems with more than one radiating structure, the conditions specified in (5) must be met when the system is fully loaded (i.e., clients absorbing maximum power available), and with all the radiating structures operating at maximum power at the same time, as per design conditions. If the design allows one or more radiating structures to be powered at a higher level while other radiating structures are not powered, then those cases must be tested as well. For instance, a device may use three RF coils powered at 5 W, or one coil powered at 15 W: in this case, both scenarios shall be tested.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com



Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 9 of 12

Limits For Maximum Permissible Exposure (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
	(A) Limits for Occ	cupational/Controlled Ex	posures	
0.3-3.0	614	1.63	*(100)	6
3.0-30	1842/f	4.89/f	*(900/f ²)	6
30-300	61.4	0.163	1.0	6
300-1500	1	1	f/300	6
1500-100,000	1	1	5	6
	(B) Limits for Genera	I Population/Uncontrolle	ed Exposure	

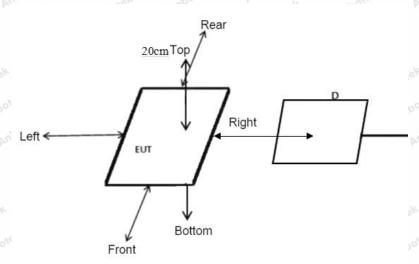
2				
0.3-1.34	614	1.63	*(100)	30
1.34-30	824/f	2.19/f	*(180/f ²)	30
30-300	27.5	0.073	0.2	30
300-1500	1	1	f/1500	30
1500-100,000	1	1	1.0	30

F=frequency in MHz

*=Plane-wave equivalent power density

RF exposure compliance will need to be determined with respect to 1.1307(c) and (d) of the FCC rules. The emissions should be within the limits at 300kHz in Table 1 of 1.1310(use the 300kHz limits for 150kHz:614V/m,1.63A/m).

2.2. Test Setup



Note: Measurements should be made at 20 cm surrounding the EUT and 20cm above the top surface of the EUT.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 10 of 12

2.3. Test Procedure

- 1) The RF exposure test was performed in anechoic chamber
- 2) The measurement probe was placed at required test distance which is between the edge of the charger and the geometric center of probe.
- 3) The highest emission level was recorded and compared with limit as soon as measurement of each points

(A, B, C, D, E) were completed.(A is the right, B is the back, C is the left, D is the front, and E is the top.)

4) The EUT was measured according to the dictates of KDB 680106 D01 v04

Remark; The EUT's test position A, B, C, D and E is valid for the E and H field measurements.

2.4. Test Result

2.4.1. Equipment Approval Considerations item 5.b of KDB 680106 D01 v04.

- (1) The power transfer frequency is below 1 MHz.
- The device operate in the frequency range 115-205kHz.
- (2) The output power from each transmitting element (e.g., coil) is less than or equal to 15 watts.The maximum output power of the primary coil is 15W.
- (3) A client device providing the maximum permitted load is placed in physical contact with the transmitter (i.e., the surfaces of the transmitter and client device enclosures need to be in physical contact)
- The surfaces of the transmitter and client device enclosures is in physical contact.
- (4) Only § 2.1091-Mobile exposure conditions apply (i.e., this provision does not cover § 2.1093-Portable exposure conditions).
 - The EUT is a Mobile exposure conditions
- (5) The E-field and H-field strengths, at and beyond 20 cm surrounding the device surface, are demonstrated to be less than 50% of the applicable MPE limit, per KDB 447498, Table 1. These measurements shall be taken along the principal axes of the device, with one axis oriented along the direction of the estimated maximum field strength, and for three points per axis or until a 1/d (inverse distance from the emitter structure) field strength decay is observed. Symmetry considerations may be used for test reduction purposes. The device shall be operated in documented worst-case compliance scenarios (i.e., the ones that lead to the maximum field components), and while all the radiating structures (e.g., coils or antennas) that by design can simultaneously transmit are energized at their nominal maximum power.

- Conducted the measurement with the required distance and the test results please refer to the section 2.4.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com Code:AB-RF-05-b

www.anbotek.com.cn

400-003-0500





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 11 of 12

- (6) For systems with more than one radiating structure, the conditions specified in (5) must be met when the system is fully loaded (i.e., clients absorbing maximum power available), and with all the radiating structures operating at maximum power at the same time, as per design conditions. If the design allows one or more radiating structures to be powered at a higher level while other radiating structures are not powered, then those cases must be tested as well. For instance, a device may use three RF coils powered at 5 W, or one coil powered at 15 W: in this case, both scenarios shall be tested.
 - The EUT is one radiating structure.

2.4.2. Environmental evaluation and exposure limit according to FCC CFR 47 part 1, 1.1307(b), 1.1310

Temperature:	22.5°C	Anboten	Relative Humidity:	49 %
Pressure:	1012 hF	a subote	Test Voltage:	AC 120V, 60Hz for adapter

E-Field Strength at 20 cm surrounding the EUT and 20cm above the top surface of the EUT

Battery power	Frequency Range (KHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Reference Limit (V/m)	Limits Test (V/m)
1%	115-205	0.371	0.461	0.411	0.421	0.541	307	614
50%	115-205	1.394	1.834	1.324	1.454	1.624	307	614
99% 🔊	115-205	2.379	2.779	2.389	2.339	2.799	307	614
Stand-by	115-205	0.409	0.559	0.399	0.389	0.529	307	614

H-Field Strength at 20 cm surrounding the EUT and 20cm above the top surface of the EUT

Battery power	Frequency Range (KHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Reference Limit (A/m)	Limits Test (A/m)
1%	115-205	0.039	0.061	0.067	0.051	0.061	0.815	1.63
50%	115-205	0.319	0.409	0.309	0.309	0.479	0.815	1.63
99%	115-205	0.458	0.638	0.528	0.348	0.338	0.815	1.63
Stand-by	115-205	0.523	0.343	0.443	0.563	0.423	0.815	1.63

Note: All the situation(full load, half load and empty load) has been tested,only the worst situation (full load 15W) was recorded in the report.

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com





Report No.: 18220WC30271002 FCC ID: 2ATX3-GF17LITE Page 12 of 12

APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph_MPE

APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

APPENDIX III -- INTERNAL PHOTOGRAPH

Please refer to separated files Appendix III -- Internal Photograph

----- End of Report -----

Shenzhen Anbotek Compliance Laboratory Limited

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 0755–26066440 Fax:(86) 0755–26014772 Email:service@anbotek.com

Code:AB-RF-05-b

